

SEMICONDUCTOR

FQP13N50C / FQPF13N50C N-Channel QFET[®] MOSFET 500 V, 13 A, 480 mΩ

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize onstate resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

Features

- 13 A, 500 V, $R_{DS(on)}$ = 480 m Ω (Max.) @ V_{GS} = 10 V, I_{D} = 6.5 A
- Low Gate Charge (Typ. 43 nC)
- Low Crss (Typ. 20 pF)
- 100% Avalanche Tested



Absolute Maximum Ratings T_c = 25°C unless otherwise noted.

Symbol	Parameter		FQP13N50C	FQPF13N50C	Units
V _{DSS}	Drain-Source Voltage		5	00	V
I _D	Drain Current - Continuous ($T_C = 25^{\circ}C$)		13	13 *	А
	- Continuous (T _C = 100°C)		8	8 *	А
I _{DM}	Drain Current - Pulsed	(Note 1)	52	52 *	А
V _{GSS}	Gate-Source Voltage		± 30		V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	860		mJ
I _{AR}	Avalanche Current	(Note 1)	13		А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	19.5		mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5		V/ns
PD	Power Dissipation (T _C = 25°C)		195	48	W
	- Derate above 25°C	1.56	0.39	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C
ΤL	Maximum lead temperature for soldering pur 1/8" from case for 5 seconds	3	°C		

* Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FQP13N50C	FQPF13N50C	Units	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.64	2.58	°C/W	
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink, Typ.	0.5		°C/W	
R _{θJA}	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W	

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Part Number		Top Mark Pack		age	age Packing Method Reel		Size	Tape W	/idth	Quantity
FQP13N50C_F105 FQP13N50C TO- FQPF13N50C_F105 FQPF13N50C TO-2		FQP13N50C	TO-:	220	Tube	N/	A	N/A		50 units
		20F Tube N/			A	N/A		50 units		
Electri	cal Cha	racteristics	T _c = 25°C un	less otherw	ise noted.					
Symbol		Parameter			Test Conditions		Min	Тур	Max	Unit
Off Cha	aracterist	ics								
BV _{DSS}	Drain-Source Breakdown Voltage		V _{GS} = 0 V, I _D = 250 μA			500			V	
ΔBV_{DSS} / ΔT_J	Breakdown Voltage Temperature		ure	$I_D = 250 \ \mu\text{A}, \text{Referenced to } 25^{\circ}\text{C}$				0.5		V/°C
	7 . 0-1-			V _{DS} = 500 V, V _{GS} = 0 V					1	μA
	Zero Gate	Voltage Drain Curr	Drain Current		V _{DS} = 400 V, T _C = 125°C				10	μA
I _{GSSF}	Gate-Body	/ Leakage Current,	Forward	V _{GS} = 30 V, V _{DS} = 0 V					100	nA
I _{GSSR}	Gate-Body	/ Leakage Current,	Reverse	V _{GS} = -	-30 V, V _{DS} = 0 V		-		-100	nA
On Cha	aracteristi	ics								
V _{GS(th)}	Gate Three	shold Voltage		V _{DS} = V	√ _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drai On-Resist	n-Source ance		V _{GS} =	10 V, I _D = 6.5 A			0.39	0.48	Ω
9 _{FS}	Forward T	ransconductance		V _{DS} = 4	40 V, I _D = 6.5 A			15		S
Dynam	ic Charac	teristics								
C _{iss}	Input Capa	acitance		V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz			1580	2055	pF	
C _{oss}	Output Ca	pacitance					180	235	pF	
C _{rss}	Reverse T	ransfer Capacitanc	е					20	25	pF
Switchi	ing Chara	acteristics								
t _{d(on)}	Turn-On D	elay Time		V -	$250 \sqrt{1} = 12 $			25	60	ns
t _r	Turn-On R	tise Time		$V_{DD} = 2$	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 13 \text{ A},$ $R_{G} = 25 \Omega$			100	210	ns
t _{d(off)}	Turn-Off D	elay Time		- NG - 2.				130	270	ns
t _f	Turn-Off F	all Time				(Note 4)		100	210	ns
Qg	Total Gate	Charge	-	V_{DS} = 400 V, I _D = 13 A, V _{GS} = 10 V (No				43	56	nC
Q _{gs}	Gate-Sour	ce Charge	-					7.5		nC
Q _{gd}	Gate-Drain	n Charge	-			(Note 4)		18.5		nC
Drain-S	Source Di	ode Character	istics ar	nd Max	imum Ratings					
<u></u> s	Maximum	Continuous Drain-	Source Dic	de Forw	ard Current				13	Α
I _{SM}	Maximum	Pulsed Drain-Sour	ce Diode F	orward (Current				52	Α
V _{SD}	Drain-Sou	rce Diode Forward	Voltage	$V_{GS} = 1$	0 V, I _S = 13 A				1.4	V
t _{rr}	Reverse R	Recovery Time	J -	$V_{GS} = 1$	0 V, Is = 13 A,			410	/	ns
Qrr	Reverse R	ecovery Charge		dl _F / dt	= 100 A/µs			4.5		uС
lotes:					· · · · ·			1		<u>.</u>
. Repetitive ra . L = 6 mH, I_A . $I_{SD} \le 13$ A, c	ating : pulse-wid $A_{AS} = 13 \text{ A}, V_{DD} = 13 \text{ Ji/dt} \le 200 \text{ A/}\mu\text{s},$	th limited by maximum jun 50 V, $R_G = 25 \Omega$, starting $V_{DD} \le BV_{DSS}$, starting $T_J =$ operating temperature	nction temper J T _J = 25°C. = 25°C.	ature.						

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Figure 11-2. Transient Thermal Response Curve for FQPF13N50C









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http://www.fairchildsemi.com/package/packageDetails.html?id=PN_TF220-003